## Notice of References Cited Application/Control No. 10/586,620 Examiner Thai Phan Applicant(s)/Patent Under Reexamination YONEDA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,120,572	10-2006	Liang, Sheng	703/26
*	В	US-7,251,594	07-2007	Krishnan, Sivaram	703/26
*	С	US-7,120,572	10-2006	Liang, Sheng	703/26
*	D	US-6,871,298	03-2005	Cavanaugh et al.	714/33
*	Е	US-7,228,266	06-2007	Sollom et al.	703/26
	F	US-			
	G	US-			
	Ι	US-			
	_	US-			
	7	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	V					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.